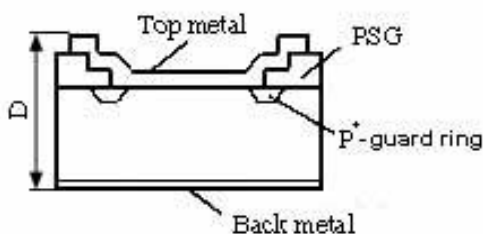
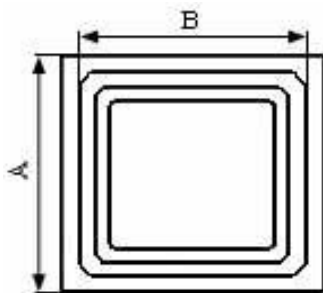




15A/40V. Die Size-123mil.

Electrical Characteristics	Symbol	Unit	Spec. limit	Die Sort
Breakdown Voltage @ $I_R=10\text{mA}$	V_{BR}	V	40	45
Average Rectified Forward Current	$I_{F(AV)}$	A	15,0	-
DC Forward Voltage @ 25°C, $I_F=15,0\text{A}$	V_F	V	0,51	0,49
Maximum Reverse Current @ 25°C, $V_R=45\text{V}$ @ 25°C, $V_R=40\text{V}$ @ 125°C, $V_R=40\text{V}$	I_R	mA	- 0,150 75,0	0,150 0,100 70,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)	I_{FSM}	A	250	-
Peak Repetitive Reverse Surge Current @ 2,0µs, $f=1\text{kHz}$., $T_J<150^\circ\text{C}$.	I_{RRM}	A	4,5	
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.	ESD	kV	±8 (contact)	
Voltage Rate of Change	dV/dt	V/µS	10.000	
Operating Junction Temperature	T_J	°C	150	



DIM	ITEM	µm
A_x	Wafer Form Die Size	3120
A_y		3120
B_x	Top Metal Size	2980
B_y		2980
D	Thickness	300max.
Scribe line Width		80

Top metal:

- a) **Al** – for Wire Bonding;
 - b) **Al-Ni-Ag** – for Soldering.
- Backside metal: **Ti-Ni-Ag**.